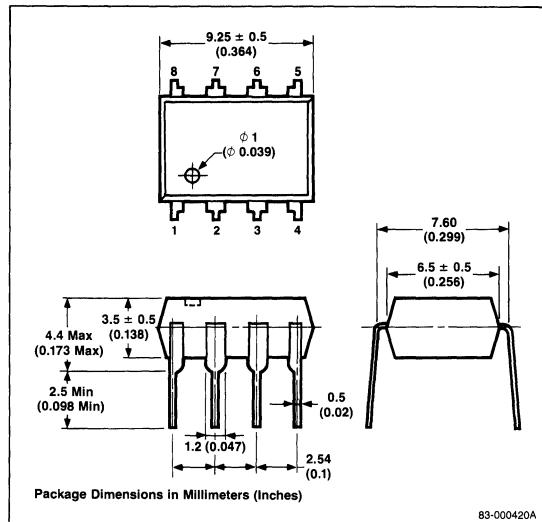


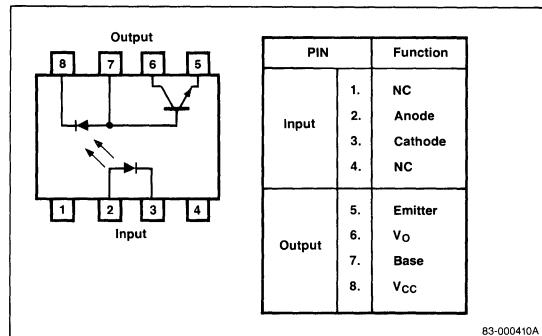
Description

The 6N136 is a high speed photo coupler containing GaAsP light emitting diode and a PN photo diode connected to a high speed transistor. The CTR is 15% min.

Package Dimensions



Pin Connection



Features

- High isolation voltage: 3000V_{DC} min
- High speed response: t_{PHL}, t_{PLH} = 300ns typ
- Compact, dual in-line plastic package

Applications

- Interface circuit for various instruments and control equipment
- Floating power supply feedback networks
- Computer and peripheral manufacture
- Pulse transformers
- High speed digital and analog line receivers

Absolute Maximum Ratings

T_A = +25°C

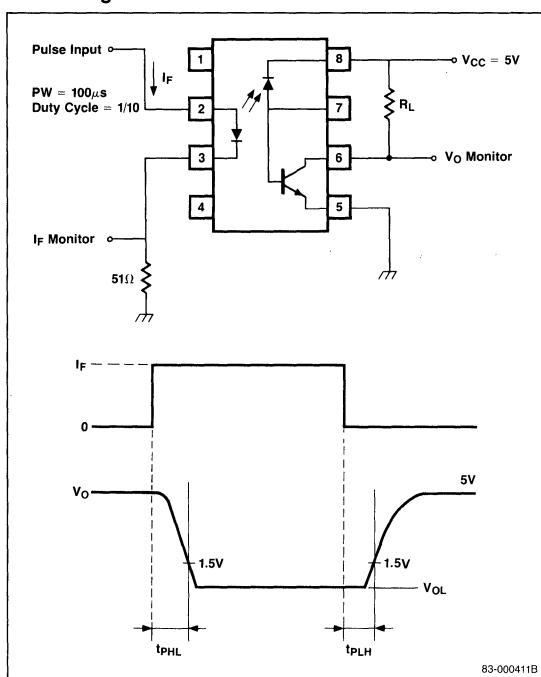
Diode	
Reverse Voltage, V _R	5V
Forward Current, I _F	25mA
Power Dissipation, P _D	45mW
Detector	
Supply Voltage, V _{CC}	-0.5V to +15V
Output Voltage, V _O	-0.5V to +15V
Output Current, I _O	8mA
Emitter to Base Voltage, V _{EBO}	5V
Power Dissipation, P _D	100mW
Isolation Voltage¹, BV	3000V _{DC}
Storage Temperature, T _{STG}	-55°C to +125°C
Operating Temperature, T _{OPT}	-55°C to +100°C

Electrical Characteristics $T_A = +25^\circ\text{C}$

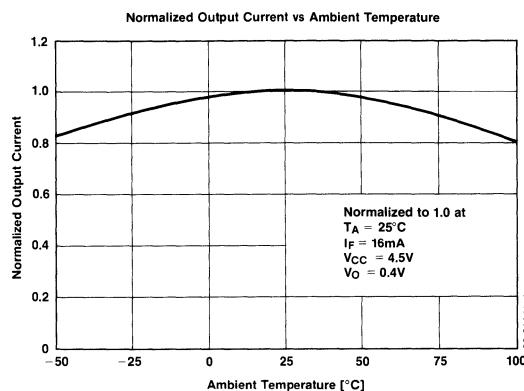
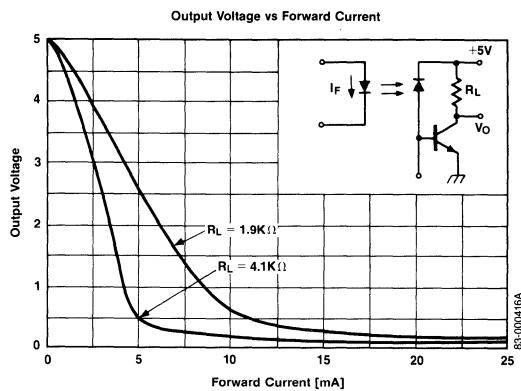
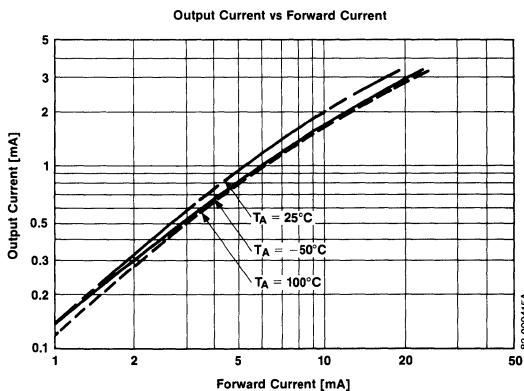
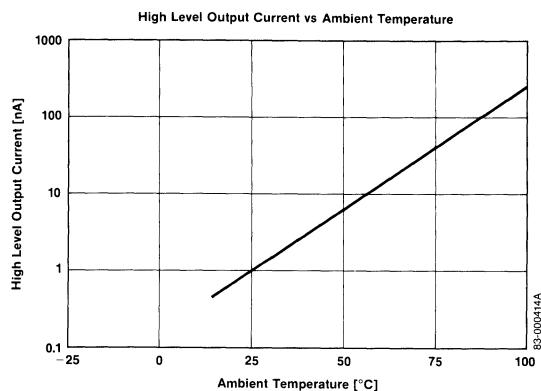
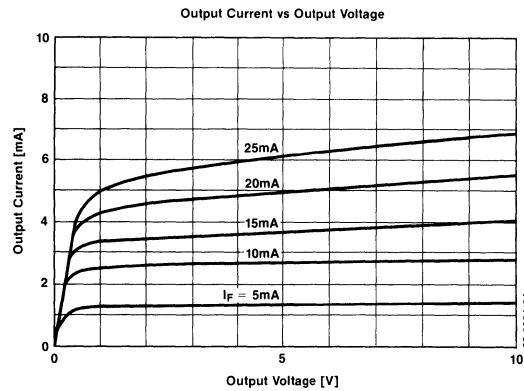
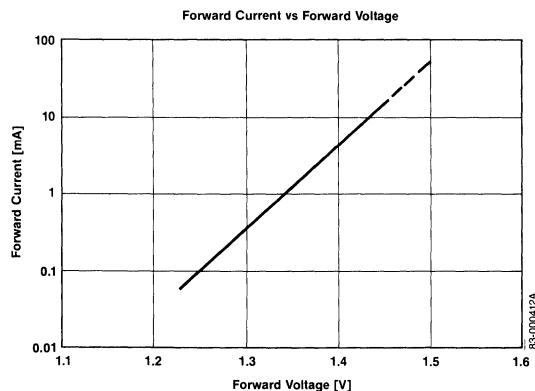
Parameter	Symbol	Limits				Test Conditions
		Min	Typ	Max	Unit	
Diode						
Forward Voltage	V_F	1.43	1.7	V	$I_F = 16\text{mA}$	
Reverse Current	I_R	0.01	10	μA	$V_R = 5\text{V}$	
Forward Voltage Temperature Coefficient	$\Delta V_F/\Delta T$	-1.51		mV/ $^\circ\text{C}$	$I_F = 16\text{mA}$	
Capacitance	C_T	60		pF	$V = 0,$ $f = 1\text{MHz}$	
Detector						
High Level Output Current	I_{OH1}	3	500	nA	$I_F = 0\text{mA},$ $V_{CC} = 5.5\text{V}$ $V_O = 5.5\text{V}$	
High Level Output Current	I_{OH2}		100	μA	$I_F = 0\text{mA},$ $V_{CC} = 15\text{V}$ $V_O = 15\text{V}$	
DC Current Gain	h_{FE}	120			$V_O = 5\text{V},$ $I_O = 3\text{mA}$	
Coupled						
Current Transfer Ratio	CTR	15	22	%	$I_F = 16\text{mA},$ $V_{CC} = 4.5\text{V}$ $V_O = 0.4\text{V}$	
Low Level Output Voltage	V_{OL}	0.1	0.4	V	$I_F = 16\text{mA},$ $V_{CC} = 4.5\text{V}$ $I_O = 2.4\text{mA}$	
Low Level Supply Current	I_{CCL}	50		μA	$I_F = 16\text{mA},$ $V_O = \text{Open},$ $V_{CC} = 15\text{V}$	
High Level Supply Current	I_{CCH}	0.01	1	μA	$I_F = 0\text{mA},$ $V_O = \text{Open},$ $V_{CC} = 15\text{V}$	
Isolation Resistance	R_{1-2}	10^{12}		Ω	$V_{IN-OUT} = 1\text{kV}$	
Isolation Capacitance	C_{1-2}	0.7		pF	$V = 0,$ $f = 1\text{MHz}$	
Propagation Delay Time to Low Output Level	t_{PHL2}	0.3/ .05	0.8/ 1.5	μs	$I_F = 16\text{mA},$ $V_{CC} = 5\text{V}$ $R_L = 1.9\text{k}\Omega/$ $4.1\text{k}\Omega$	
Propagation Delay Time to High Output Level	t_{PLH2}	0.3/ .05	0.8/ 1.5	μs	$I_F = 16\text{mA},$ $V_{CC} = 5\text{V}$ $R_L = 1.9\text{k}\Omega/$ $4.1\text{k}\Omega$	

Notes: 1. Measuring Conditions: DC voltage for 1 min at $T_A = +25^\circ\text{C}$, RH = 60% between input (pins 1, 2, 3, and 4 common) and output (pins 5, 6, 7, and 8 common).

2. Measuring circuit.

Measuring circuit

83-000411B

Typical Characteristics $T_A = +25^\circ\text{C}$ 

Typical Characteristics (cont) $T_A = +25^\circ\text{C}$ 